

Notice of References Cited	Application/Control No. 10/737,281		Applicant(s)/Patent Under Reexamination WEI ET AL.	
	Examiner MICHAEL PHAM		Art Unit 2167	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,956,731	09-1999	Bamford et al.	707/201
*	B	US-6,078,932	06-2000	Haye et al.	707/204
*	C	US-7,373,364	05-2008	Chapman, Dennis E.	707/204
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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